

Notice of References Cited

Ì	Application/Control No.	Applicant(s)/Patent Under Reexamination GEHRING ET AL.		
	Examiner	Art Unit		
	Marcos D. Pizarro-Crespo	2814	Page 1 of 1	

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NON-PATENT DOCUMENTS

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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.